

<b>Notice of References Cited</b>	Application/Control No. 10/525,089	Applicant(s)/Patent Under Reexamination INOUE ET AL.	
	Examiner Jaision P. Thomas	Art Unit 1751	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2002-208447	07-2002	JAPAN	ONORI et al.	H01R 11/01
	O	JP 11-307782	05-1999	JAPAN	TAKESHI	H01L 29/786
	P	JP 2002-203879	07-2002	JAPAN	KAZUO	H01L 21/66
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.